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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/820,257	JAIN ET AL.	
Examiner	Art Unit	
Dieu-Minh Le	2114	

Dieu-Minh Le

SEARCHED				
Class	Subclass	Date	Examiner	
714	4	12/12/2007	DML	
	47			
370	218	·		
	217			
$\Box$	351			
709	238	$\rightarrow$	$\leftarrow$	
1	239	12/12/2007	DML	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
714	4	<b>/2</b> /16/2007	DML
	47		
370	218	12/16/2007	DML
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SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
EAST search files USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM-TDB.	12/12/2007	DML
Inventor names search.	12/12/2007	DML
NPL search files [ACM & IEEE].	12/12/2007	DML
Interference search -see textsearch printout.	12/12/2007	DML